

MOSFET – N-Channel, POWERTRENCH®

30 V, 75 A, 1.3 m Ω

FDMC8010

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance. This device is well suited for applications where ultra low $R_{DS(on)}$ is required in small spaces such as High performance VRM, POL and Oring functions.

Features

- Max $R_{DS(on)} = 1.3 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 30 \text{ A}$
- Max $R_{DS(on)} = 1.8 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 25 \text{ A}$
- High Performance Technology for Extremely Low R_{DS(on)}
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC-DC Buck Converters
- Point of Load
- High Efficiency Load Switch and Low Side Switching
- Oring FET

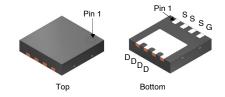
MOSFET MAXIMUM RATINGS (T_A = 25°C Unless Otherwise Noted)

Symbol	Parameter	Ratings	Units
VDS	Drain to Source Voltage	30	٧
Vgs	Gate to Source Volage (Note 4)	±20	٧
I _D		75 166 30 120	Α
Eas	Single Pulse Avalance Energy (Note 3)	153	mJ
P _D	Power Dissipation T _C = 25°C	54	W
	Power Dissipation T _A = 25°C (Note 1a)	2.4	
Тл, Тѕтс	Operating and Storage Junction Temperature Range	–55 to +150	°C

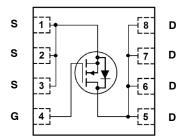
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

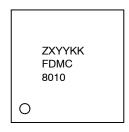
Symbol	Parameter	Ratings	Unit
Rejc	Thermal Resistance, Junction to Case	2.3	°C/W
Reja	Thermal Resistance, Junction to Ambient (Note 1a)	53	°C/W



WDFN8 3.3x3.3, 0.65P (Power 33) CASE 483AW



MARKING DIAGRAM



Z = Assembly Plant Code
XYY = Date Code (Year & Week)
KK = Lot Traceability Code
FDMC8010 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC8010	WDFN8 (Power 33)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D">BRD8011/D.

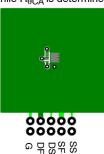
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARAC	TERISTICS					-
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 1 mA, referenced to 25°C		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
ON CHARACT	TERISTICS	•		· -		·-
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	1.2	1.5	2.5	V
$\Delta V_{GS(th)}/\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 1 mA, referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V, } I_D = 30 \text{ A}$ $V_{GS} = 4.5 \text{ V, } I_D = 25 \text{ A}$		0.9	1.3	mΩ
				1.3	1.8	
		V _{GS} = 10 V, I _D = 30 A, T _J = 125°C		1.3	2	1
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 30 A		188		S
DYNAMIC CH	ARACTERISTICS			-		
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V,		4405	5860	pF
C _{oss}	Output Capacitance	f = 1 MHz		1570	2090	pF
C _{rss}	Reverse Transfer Capacitance			167	250	pF
R_g	Gate Resistance		0.1	0.5	1.25	Ω
SWITCHING C	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 30 \text{ A}, V_{GS} = 10 \text{ V},$		15	27	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$		7.5	15	ns
t _{d(off)}	Turn-Off Delay Time			40	64	ns
t _f	Fall Time			5.3	11	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V V _{DD} = 15 V		67	94	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $I_D = 30 \text{ A}$		32	45	nC
Qgs	Gate to Source Charge			10		nC
Qgd	Gate to Drain "Miller" Charge			9.5		nC
DRAIN-SOUR	ICE DIODE CHARACTERISTICS					-
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2 A (Note 2)		0.6	1.2	V
		V _{GS} = 0 V, I _S = 30 A (Note 2)		0.7	1.2]
t _{rr}	Reverse Recovery Time	I _F = 30 A, di/dt = 100 A/μs		49	78	ns
Q _{rr}	Reverse Recovery Charge			29	46	nC

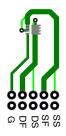
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper.

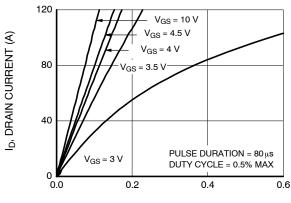


b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.
 E_{AS} of 153 mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 32 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 47 A.
 As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS

T_J = 25°C Unless Otherwise Noted



V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

5 NORMALIZED DRAIN TO SOURCE ON-RESISTANCE PULSE DURATION = 80μs DUTY CYCLE = 0.5% MAX V_{GS} = 3 V 3 $V_{GS} = 4 V$ V_{GS} = 3.5 V 2 V_{GS} = 10 V $V_{GS} = 4.5 \text{ V}$ 0 40 80 120

ID, DRAIN CURRENT (A)

Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs Drain **Current and Gate Voltage**

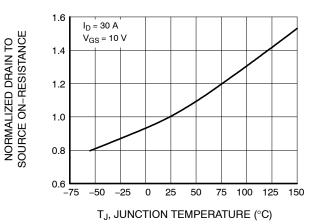


Figure 3. Normalized On Resistance vs **Junction Temperature**

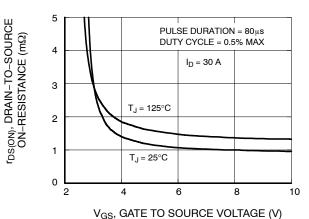


Figure 4. On-Resistance vs Gate to Source Voltage

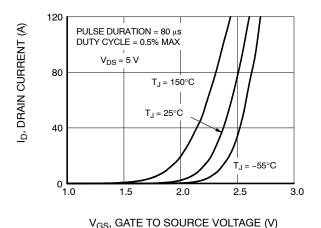
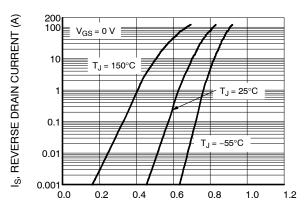


Figure 5. Transfer Characteristics



V_{SD}, BODY DIODE FORWARD VOLTAGE (V)

Figure 6. Source to Drain Diode Forward **Voltage vs Source Current**

TYPICAL CHARACTERISTICS (continued)

T_J = 25°C Unless Otherwise Noted

CAPACITANCE (pF)

ID, DRAIN CURRENT (A)

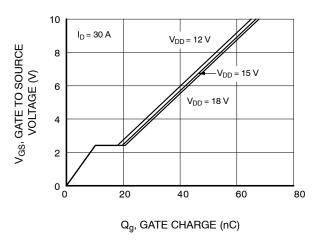


Figure 7. Gate Charge Characteristics

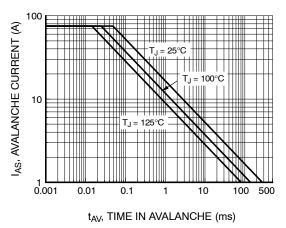
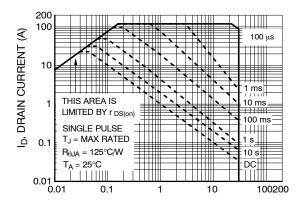
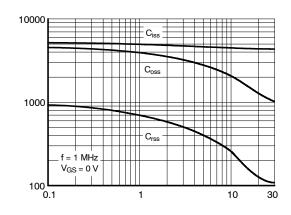


Figure 9. Unclamped Inductive Switching Capability



V_{DS}, DRAIN TO SOURCE VOLTAGE (V) Figure 11. Forward Bias Safe Operating Area



V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 8. Capacitance vs Drain to Source Voltage

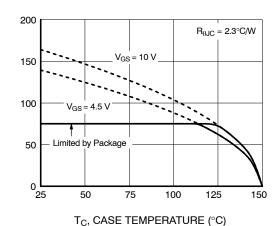
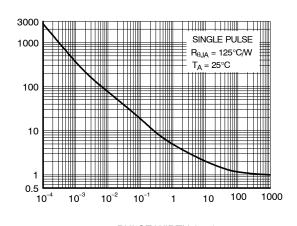


Figure 10. Maximum Continuous Drain **Current vs Case Temperature**



t, PULSE WIDTH (sec)

Figure 12. Single Pulse Maximum Power Dissipation

P_(PK), PEAK TRANSIENT POWER (W)

TYPICAL CHARACTERISTICS (continued)

T_J = 25°C Unless Otherwise Noted

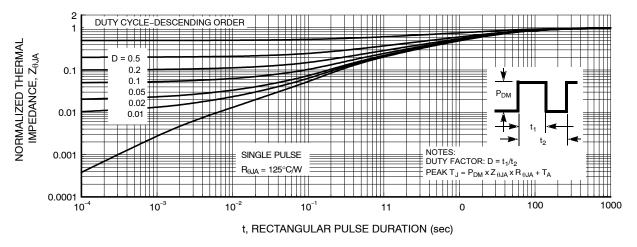


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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Α

5

TOP VIEW

В



TERMINAL #1

INDEX AREA

(D/2 X E/2)

☐ aaa C

WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

DATE 22 MAR 2024

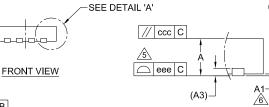
NOTES:

C

SEATING

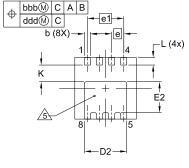
PLANE

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



aaa C

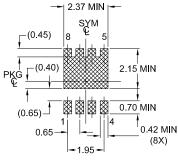
2X



BOTTOM VIEW

LAND PATTERN RECOMMENDATION

DETAIL A



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS			
Diivi	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1			0.05	
А3	0.20 REF			
b	0.27	0.32	0.37	
D	3.30 BSC			
D2	2.17	2.27	2.37	
Е	3.30 BSC			
E2	1.56	1.66	1.76	
е	0.65 BSC			
e1	1.95 BSC			
K	0.90			
L	0.30	0.40	0.50	
aaa	0.10			
bbb	0.10			
ccc	0.10			
ddd	0.05			
eee	0.05			

MILLIMETERS

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1	

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